

HON HAI Precision IND.CO.,LTD.

5F-1,5,Hsin-An Road,
Hsinchu Science-Based Industrial Park,
Taiwan, R.O.C.

Tel: 886-3-5784975 Fax: 886-3-5783038

Reliability Test Report for

BFX-AT100

(Long term solution LED

(insulation glue))

Prepared by Jackson Huang
Test Engineer, HWQA Engineering Dept.

Checked by Kenji Chen
Supervisor, HWQA Engineering Dept.

Approved by Jy Deng
Manager, HWQA Engineering Dept.

Revision Change History

Revision	Description of Change	Date
1.0	Initial Release	08/27/2021

HON HAI PRECISION IND. CO., LTD.

Notice:

All rights reserved. Except for distribution within company that authorized by Foxconn, passing on and copying of this document, use and communication of its contents with the third party is not permitted without written authorization from HON HAI PRECISION IND. CO., LTD.

Table of Contents

Table of Contents 1

Purpose: 2

Scope: 2

The summary of test items: 3

Panel Drawing: 4

Test setup and function test: 4

1. Continuation of temperature cycle 5

2. High Temperature and Humidity Test 6

3. Thermal Shock Test 7

4. MTBF Demonstration Test 9

Purpose:

1. Provide a formal functional demonstration of the product design reliability.
2. Identify any design discrepancies.
3. Reliability assurance of trial samples which are designed and fabricated in accordance with the customer's product specifications.
4. Conduct robustness testing on early production samples in accordance to customer's product environmental testing specification.

Scope:

This document describes the performance requirements, validation criteria, and the validation tests which focus on BFX-AT100 product.

The DUT H/W version is 04L1 and S/W revision is v15.523.6.

For LED Issue - Long term solution LED (insulation glue).

The summary of test items:

No.	Item	Test Condition	Q'ty	Period	Pass Criteria
1	Continuation of temperature cycle	1. Operating in high and low temperature environment at 50/- 5°C 2. 50°C with 1°C/min, Dwell 12 hrs ; - 5°C with 1°C/min, Dwell 12 hrs, total 5 cycles	3	6 days	1. No functional failures both before and after the test 2. No performance degradation after the functional test 3. No visual damage to the products after inspection, such as peeling, discoloration, etc.
2	High Temperature & Humidity Test	Power on, Operation Ta = 50°C, Humi. = 90%R.H. for 120 hours	3	5 days	1. No functional failures both during and after the test 2. No performance degradation during the functional test 3. No visual damage to the products after inspection, such as peeling, discoloration, etc.
3	Thermal Shock Test	Power off , non-operation Ta= - 20°C (30min) ~ 70°C (30min) 120 cycles Transfer time: 5 min	3	6 days	1. No functional failures both before and after the test 2. No performance degradation after the functional test 3. No visual damage to the products after inspection, such as peeling, discoloration, etc.
4	MTBF Demonstration Test	1. System temperature (Tn): 25°C 2. Test environment (Ta) Temp.: 50°C 3. Activation Energy(EA): 0.7 4. Confidence level: 90% 5. Test day: 30 days 6. MTBF: 50,000 Hours (5 years)	20	30 days	1. No functional failures both before and after the test 2. No performance degradation after the functional test 3. No visual damage to the products after inspection, such as peeling, discoloration, etc.

Panel Drawing:

Front



Rear

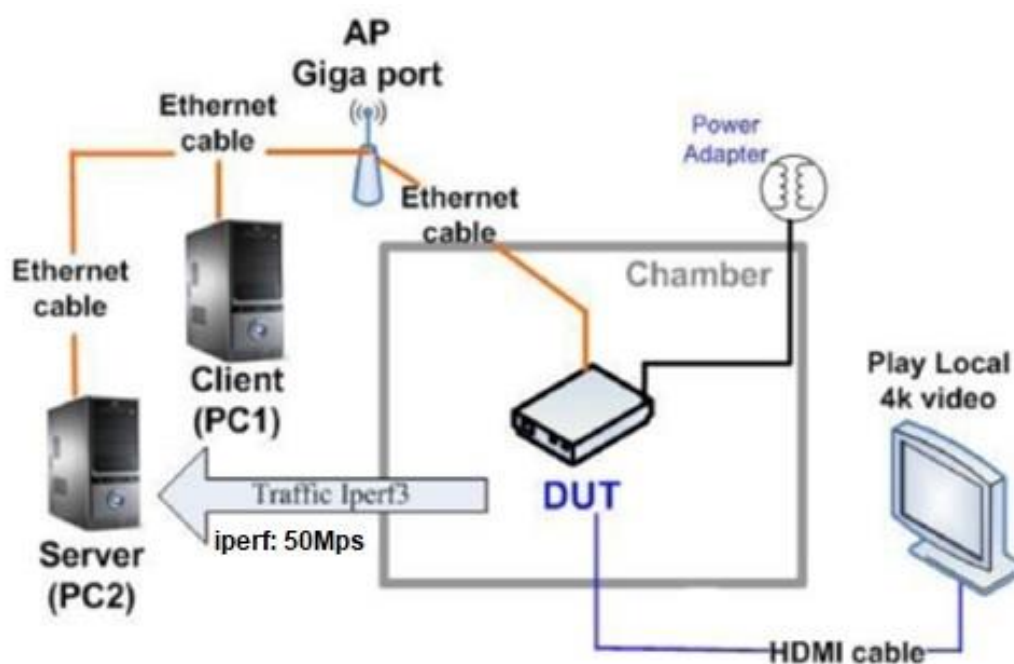


Adapter



ANY0502W-NOS
Input: 100-250V
50/60Hz, 0.5A
Output: DC 5V/2A

Test setup and function test:

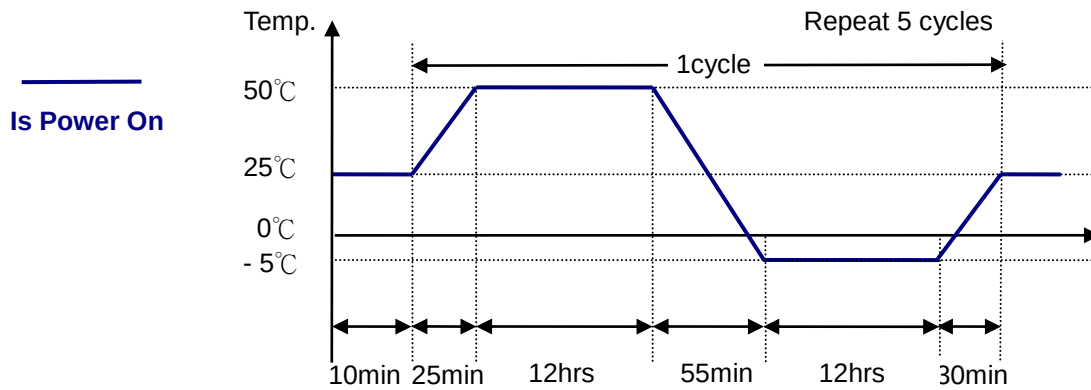


1. Continuation of temperature cycle**Purpose:**

To demonstrate that products can operate in the high/low temperature and high humidity environment.

Quantity: 3 units.

Test Objective: Operating in high/low Temperature and high Humidity.

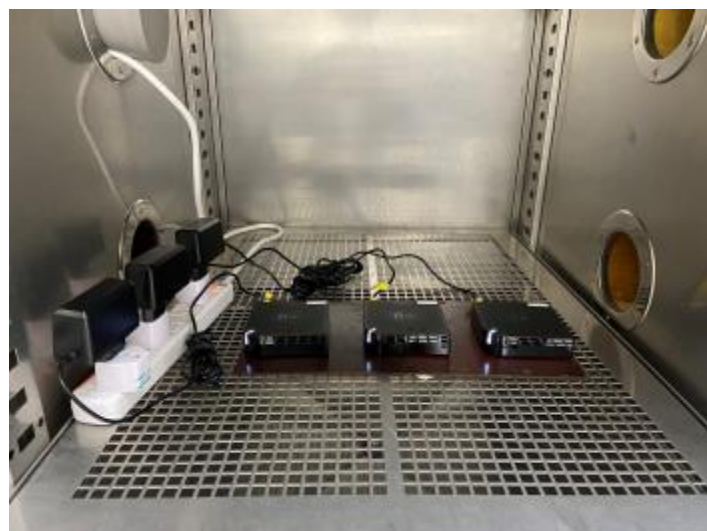
Test Profile:**Test Procedure:**

1. Power on, then activated in full function and operation.
2. Start test at 25°C for 10 min.
3. Ramp the temperature to 50°C for 12 hours.
4. Ramp the temperature to - 5°C for 12 hours.
5. Repeat item 3 ~ 4 for 5 cycles.

Pass Criteria:

1. No functional failures both during and after the test.
2. No performance degradation during the functional test.
3. No visual damage to the products after inspection, such as peeling, discoloration, etc.

Basis for Profile: IEC 60068-2-30.



2. High Temperature and Humidity Test

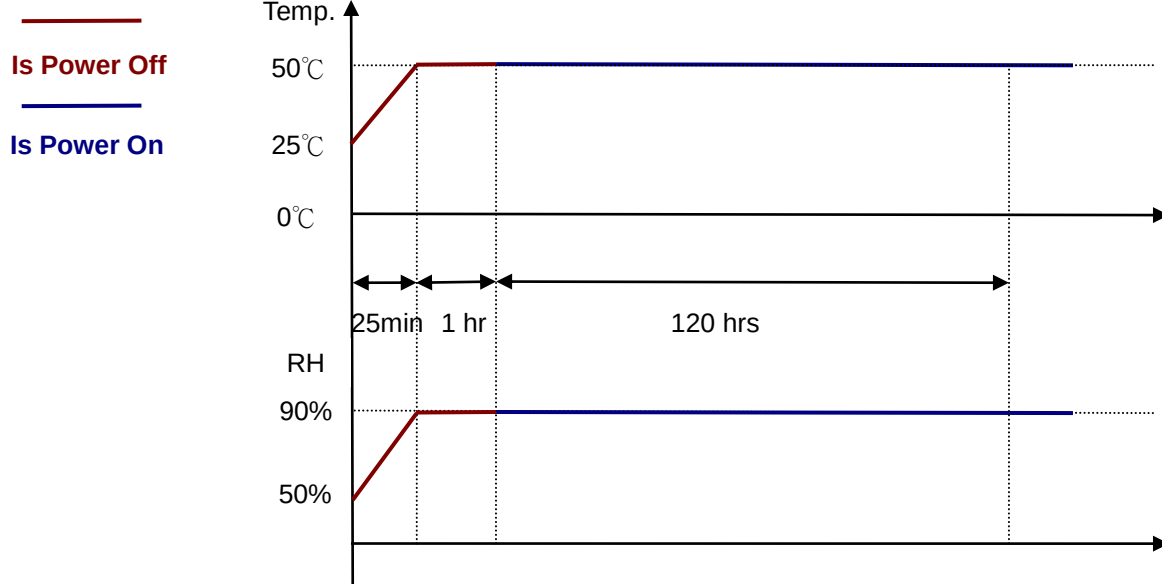
Purpose:

To demonstrate that products can withstand the high limit temperature and the high limit humidity of an operating environment.

Quantity: 3 units.

Test Objective: Operating Temperature and Humidity: Temp. + 50°C and RH 90%, Duration: 5 days

Test Profile:



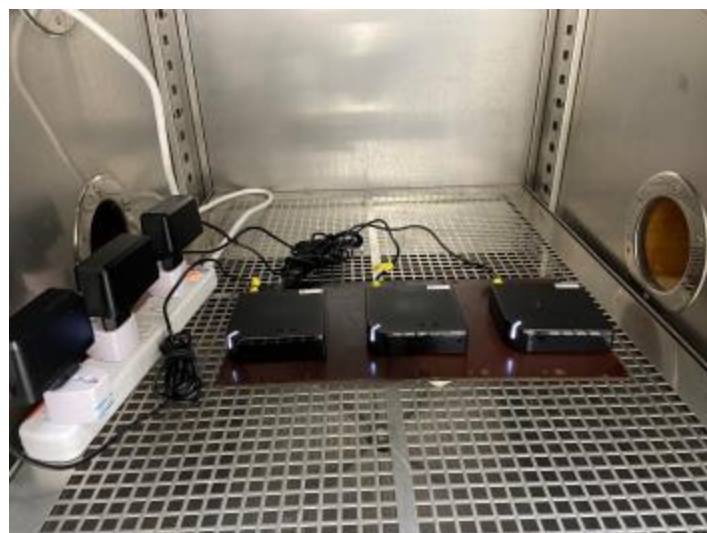
Test Procedure:

1. Power off.
2. Start test at 25°C and RH 50%.
3. Ramp the temperature to 50°C and RH 90% in 25 minutes, then hold for 1 hour.
4. Power on the test units.
5. Hold 50°C, RH 90% for 120 hours.

Pass Criteria:

1. No functional failures both during and after the test.
2. No performance degradation during the functional test.
3. No visual damage to the products after inspection, such as peeling, discoloration, etc.

Basis for Profile: MIL-STD-202F Method 103B



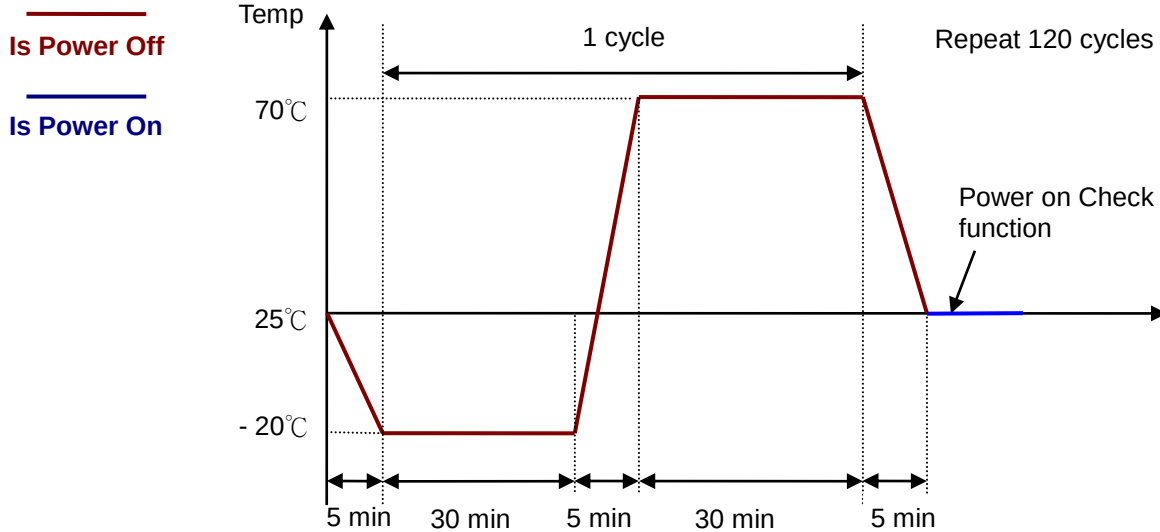
3. Thermal Shock Test

Purpose:

To demonstrate that the product can be operated after high & low temperature shock environment.

Quantity: 3 units.

Test Objective: Ta = - 20°C (30minutes) ~ 70°C (30minutes), Cycle: 120 cycles,
Transfer time: 5 minutes.

Test Profile:**Test Procedure:**

1. Power off.
2. Start test at 25°C.
3. Ramp the temperature to - 20°C and hold for 30 minutes.
4. Ramp the temperature to 70°C and hold for 30 minutes.
5. Transfer time: 5 minutes
6. After repeat 120 cycles. Power on, then activated in full function and operation.

Pass Criteria:

1. No functional failures both before and after the test.
2. No performance degradation after the functional test.
3. No visual damage to the products after inspection, such as peeling, discoloration, etc.

Basis for Profile: MIL – STD-810F Method 503.4 Procedure I.



Test Result:

No.	SN	Before	After	Result
1	2149688001202199000051			Visually no abnormalities
2	2149688001202199000052			Visually no abnormalities
3	2149688001202199000053			Visually no abnormalities

4. MTBF Demonstration Test

Purpose:

This document describes the RDT test.

Quantity: 20 units.

Test Objective: Operating in 50 deg C Temperature for 30 days.

Test Block Diagram:

The RDT (Reliability Demonstration Test) test is necessary to quantify the expected service life of a product. It specifies how the test is to be performed. Demonstrated MTBF (Mean Time Between Failure), the MTBF target is 50,000 hours.

If it based on the Foxconn standard MTBF calculation formula. Demonstrated MTBF (Mean Time Between Failure) will be based on the methods defined in MIL-STD-781D. The MTBF target is 50,000 hours. Based on 90 % confidence level, it will take **30 days with 20 pieces** of samples under 50 deg C. The formula below shows how the MTBF is defined.

$$\frac{(\text{Testing hours}) * (\text{Acceleration Factor}) * (\text{Number of U.U.T})}{(\text{Confidence Level Factor})}$$

Acceleration factor (A.F) = 8.246797274

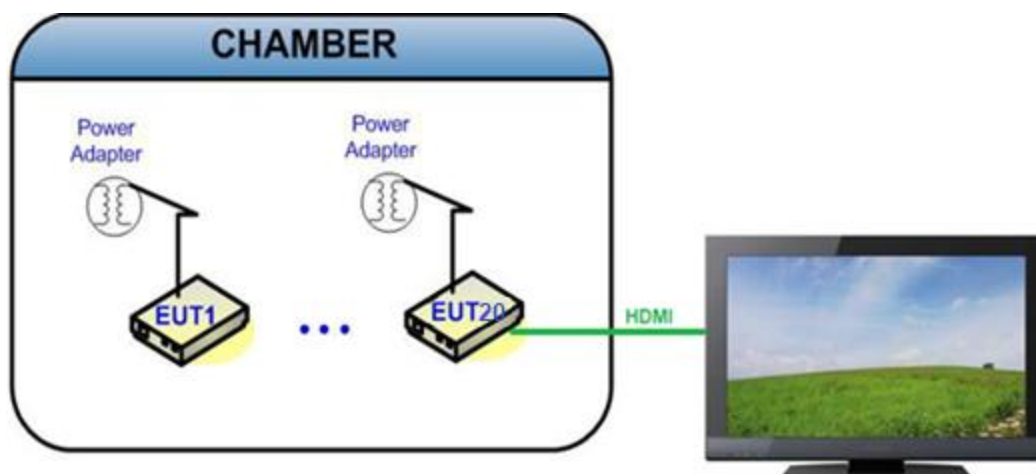
Ta = Acceleration Temperature = 50 Deg.C

Tb = Ambient Temperature = 25 Deg.C

$$e^{\frac{0.7}{8.6173324 \times 10^{-5}} * \left[\frac{1}{273+Tb} - \frac{1}{273+Ta} \right]} = 8.246797274$$

Confidence Level Factor = 4.605 (based on Confidence Level 90% and 0 Defect)

It needs **30 days** to test with 0 defects to achieve the goal of **51574.15511 hours** MTBF.



Test Procedure:

1. Power on, then activated in full function and operation.
2. Ramp the temperature to 50°C for 30 days.

Pass Criteria:

1. No functional failures both during and after the test.
2. No performance degradation during the functional test.
3. No visual damage to the products after inspection, such as peeling, discoloration, etc.

Basis for Profile: MIL-STD-781D.**Test Result:**

No.	SN	Before	After	Result
1	2149688001202199000031			Visually no abnormalities
2	2149688001202199000032			Visually no abnormalities
3	2149688001202199000033			Visually no abnormalities

4	2149688001202199000034			Visually no abnormalities
5	2149688001202199000035			Visually no abnormalities
6	2149688001202199000036			Visually no abnormalities
7	2149688001202199000037			Visually no abnormalities

8	2149688001202199000038			Visually no abnormalities
9	2149688001202199000039			Visually no abnormalities
10	2149688001202199000040			Visually no abnormalities
11	2149688001202199000054			Visually no abnormalities

12	2149688001202199000055			Visually no abnormalities
13	2149688001202199000056			Visually no abnormalities
14	2149688001202199000057			Visually no abnormalities
15	2149688001202199000058			Visually no abnormalities

16	2149688001202199000059			Visually no abnormalities
17	2149688001202199000060			Visually no abnormalities
18	2149688001202199000061			Visually no abnormalities
19	2149688001202199000062			Visually no abnormalities

20	2149688001202199000063		Visually no abnormalities
----	------------------------	--	---------------------------